

Application/Control No.	Applicant(s)/Patent under Reexamination
09/262,934	CHEN ET AL.
Examiner	Art Unit
Mohamed Charioui	2857

SEARCHED			
SEARCHED			
Class	Subclass	Date	Examiner
702	64, 66, 69, 70-72, 75	9/20/2005	МС
702	77, 106	9/20/2005	МС
702	111, 183	9/20/2005	МС
702	188, 189	9/20/2005	МС
702	190, 191	9/20/2005	МС
702	194, 197	9/20/2005	МС
702	199	9/20/2005	MC
34	528	9/21/2005	МС
318	799	9/21/2005	МС
367	47-50	9/21/2005	МС
Search	updated	3/4/2006	МС
382	280, 291	3/4/2006	МС

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
702	194	3/4/2006	МС
382	280	3/4/2006	МС
382	291	3/4/2006	мс

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
East: Consulted with Hal Wachsman	9/21/2005	МС	
East: (clothes near dryer) and (phase near angle)	9/20/2005	МС	
East: (((moving or rolling) near average) with points) and convol\$8 and wavelet	9/20/2005	MC	
East: (((moving or rolling) near average)) and convol\$8 and wavelet	9/20/2005	мс	
East: (((moving or rolling) near average)) and convol\$8 and wavelet	9/21/2005	мс	
East: (convol\$6 with ("FFT" or "fast fourier transform")) and ((moving or rolling) near average)	9/21/2005	МС	
East: phase with convol\$6 with wavelet	9/21/2005	мс	
East: (sampl\$4 with convol\$6 with sensor\$1) and wavelet	9/21/2005	МС	

Search	Notes	(continu	ıed)
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